

# Search Notes



Application/Control No.

10/712,788

Examiner

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Applicant(s)/Patent under Reexamination

DELMULLE ET AL.

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
455	41.2,41.3, 550.1 552.1	5/6/2006	YP
	556.1		
	557		
	559		
<i>updated search</i>		<i>9/28/06</i>	<i>YP</i>

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST(USPG-PUB,USPAT)	5/6/2006	YP